

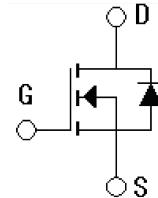
### Features

- Super junction MOSFET technology
- Ultra-low gate charge
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability
- RoHS product



### Applications

- High frequency switching mode power supply
- Electronic ballast
- UPS



### Absolute Ratings (Tc=25°C)

| Parameter  | Symbol                            | Value    | Unit |
|--|-----------------------------------|----------|------|
| Drain-Source Voltage   | V <sub>DSS</sub>                  | 900      | V    |
| Drain Current-continuous<br>T=25°C<br>T=100°C  | I <sub>D</sub> T=25°C             | 8        | A    |
|  | T=100°C                           | 5        | A    |
| Drain Current-pulse<br>(note 1)  | I <sub>DM</sub>                   | 32       | A    |
| Gate-Source Voltage  | V <sub>GS</sub>                   | ±30      | V    |
| Avalanche Current(note 1)  | I <sub>AR</sub>                   | 2.7      | A    |
| Single pulse avalanche energy<br>(note 2)  | E <sub>AS</sub>                   | 122      | mJ   |
| Power Dissipation  | PD<br>TC=25°C                     | 104      | W    |
|  | Derate above<br>25°C              | 1.43     | W/°C |
| Peak Diode Recovery dv/dt<br>(note 3)  | dv/dt                             | 15       | V/ns |
| MOSFET dv/dt ruggedness(not 4)   | dv/dt                             | 50       |      |
| Operating and Storage<br>Temperature Range   | T <sub>J</sub> , T <sub>STG</sub> | -55~+150 | °C   |
| Maximum Lead Temperature for<br>Soldering Purposes   | T <sub>L</sub>                    | 300      | °C   |
| Insulation withstand voltage<br>(RMS) from all three leads to<br>external<br>heat sink (t = 1 s; TC = 25 °C) | V <sub>IISO</sub>                 | 2.5      | kV   |

**Electrical Characteristics( $T_{CASE}=25^\circ C$  unless otherwise specified)**

| <b>Parameter</b>                             | <b>Symbol</b>                | <b>Tests conditions</b>                     | <b>Min</b> | <b>Type</b> | <b>Max</b> | <b>Units</b>  |
|--|------------------------------|---|------------|-------------|------------|---------------|
| Drain-Source Voltage                         | $BV_{DSS}$                   | $I_D=250\mu A, V_{GS}=0V$                   | 900        | -           | -          | V             |
| Breakdown Voltage<br>Temperature Coefficient | $\Delta BV_{DSS}/\Delta T_J$ | $I_D=250\mu A$ , referenced to $25^\circ C$ | -          | 1.05        | -          | V/ $^\circ C$ |
| Zero Gate Voltage Drain Current              | $I_{DSS}$                    | $V_{DS}=900V, V_{GS}=0V, T_c=25^\circ C$    | -          | -           | 1          | $\mu A$       |
|  |                              | $V_{DS}=900V, T_c=125^\circ C$              | -          | -           | 50         | $\mu A$       |
| Gate body leakage current                    | $I_{GSS}$                    | $V_{DS}=0V, V_{GS}=\pm 30V$                 | -          | -           | $\pm 100$  | nA            |

**On-Characteristics**

|                                   |              |                                  |     |      |      |          |
|-----------------------------------|--------------|----------------------------------|-----|------|------|----------|
| Gate Threshold Voltage            | $V_{GS(th)}$ | $V_{DS}=V_{GS}, I_D=250\mu A$    | 2.5 | -    | 4.5  | V        |
| Static Drain-Source On-Resistance | $R_{DS(ON)}$ | $V_{GS}=10V, I_D=4A$             | -   | 0.70 | 0.90 | $\Omega$ |
| Forward Trans-conductance         | $g_{FS}$     | $V_{DS}=40V, I_D=4A$<br>(note 5) | -   | 5.6  | -    | S        |

**Dynamic Characteristics**

|                              |           |                                   |   |     |   |    |
|------------------------------|-----------|-----------------------------------|---|-----|---|----|
| Input capacitance            | $C_{iss}$ | $V_{DS}=25V, V_{GS}=0V, f=1.0MHz$ | - | 687 | - | pF |
| Output capacitance           | $C_{oss}$ |                                   | - | 67  | - | pF |
| Reverse transfer capacitance | $C_{rss}$ |                                   | - | 12  | - | pF |

**Electrical Characteristics( $T_{CASE}=25^\circ C$  unless otherwise specified)**

| <b>Parameter</b>                 | <b>Symbol</b> | <b>Tests conditions</b>                               | <b>Min</b> | <b>Type</b> | <b>Max</b> | <b>Units</b> |
|----------------------------------|---------------|---|------------|-------------|------------|--------------|
| <b>Switching-Characteristics</b> |               |   |            |             |            |              |
| Turn-On delay time               | $t_{d(on)}$   | $V_{DD}=450V, I_D=4A, R_{GEN}=25\Omega$<br>(note 5,6) | -          | 32          | -          | ns           |
| Turn-On rise time                | $t_r$         |   | -          | 20          | -          | ns           |
| Turn-Off delay time              | $t_{d(off)}$  |   | -          | 52          | -          | ns           |
| Turn-Off rise time               | $t_f$         |   | -          | 14          | -          | ns           |
| Total Gate Charge                | $Q_g$         | $V_{DS}=720V, I_D=4A, V_{GS}=10V$<br>(note 5,6)       | -          | 18.4        | -          | nC           |
| Gate-Source charge               | $Q_{gs}$      |   | -          | 6.2         | -          | nC           |
| Gate-Drain charge                | $Q_{gd}$      |   | -          | 4.5         | -          | nC           |

**Drain-Source Diode Characteristics and Maximum Ratings**

|   |          |   |   |      |     |    |
|---|----------|---|---|------|-----|----|
| Diode Forward Voltage<br>(note 3)                           | $V_{SD}$ | $V_{GS}=0V, I_S=8A$   | - | -    | 1.3 | V  |
| Maximum Pulsed<br>Drain-Source<br>Diode Forward Current     | $I_{SM}$ | -   | - | -    | 32  | A  |
| Maximum Continuous<br>Drain Source Diode<br>Forward Current | $I_S$    | -   | - | -    | 8   | A  |
| Reverse recovery time                                       | $t_{rr}$ | $V_{GS}=0V, V_{DD}=60V$   | - | 254  | -   | ns |
| Reverse recovery charge                                     | $Q_{rr}$ | $I_S=4A \frac{dI_F}{dt}=100A/\mu s$<br>$T_c=25^\circ C$ (note 5)                  | - | 1260 | -   | nC |
| Reverse recovery time                                       | $t_{rr}$ | $V_{GS}=0V,$<br>$I_S=3A \frac{dI_F}{dt}=100A/\mu s$<br>$T_c=100^\circ C$ (note 5) | - | 332  | -   | ns |
| Reverse recovery charge                                     | $Q_{rr}$ |   | - | 1530 | -   | nC |

**Thermal Characteristic**

| Parameter                                  | Symbol        | Value | Unit         |
|--|---------------|-------|--------------|
| Thermal Resistance,<br>junction to Case    | $R_{th}(j-C)$ | 1.2   | $^\circ C/W$ |
| Thermal Resistance, Junction to<br>Ambient | $R_{th}(j-A)$ | 40    | $^\circ C/W$ |

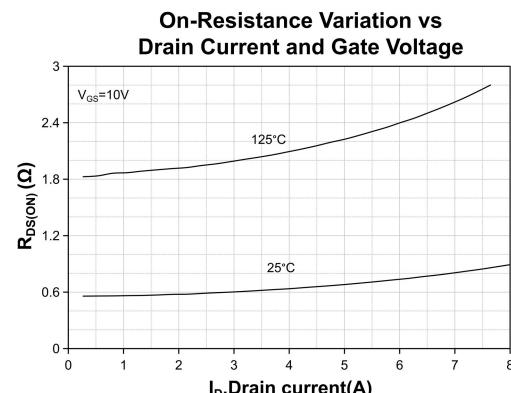
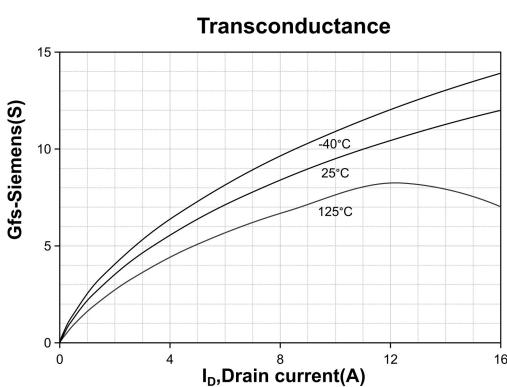
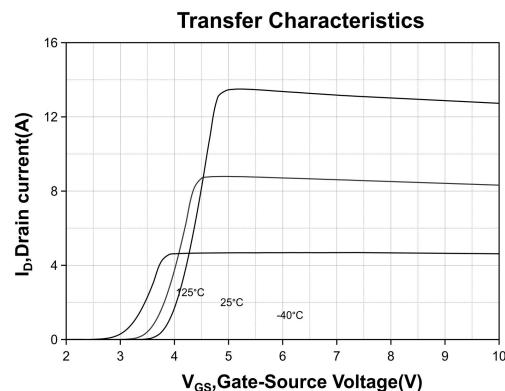
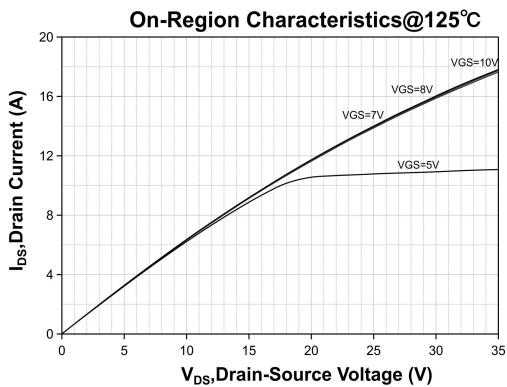
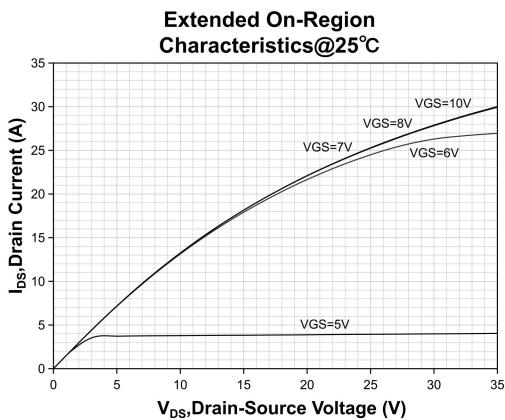
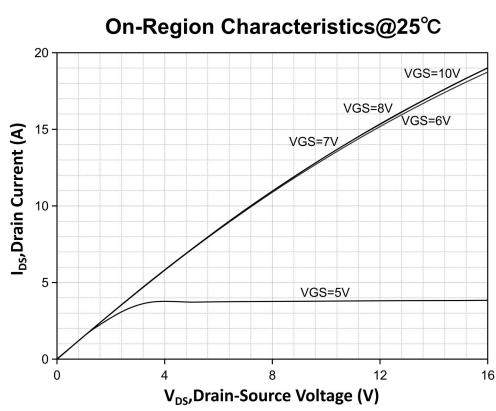
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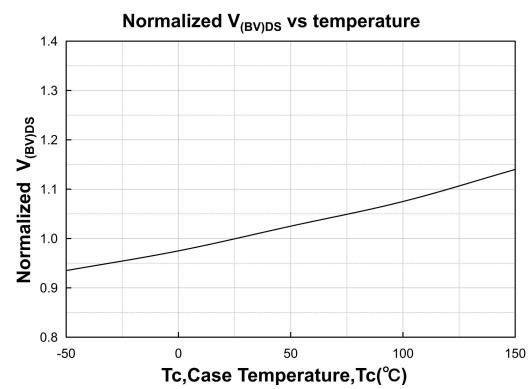
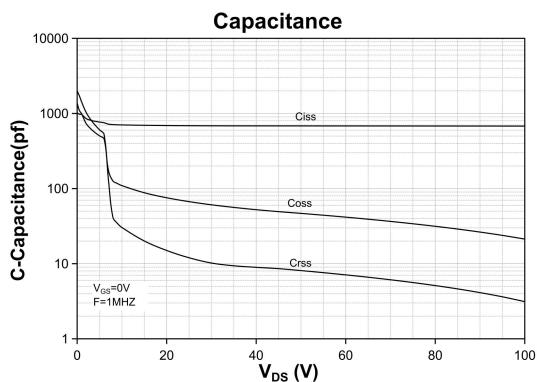
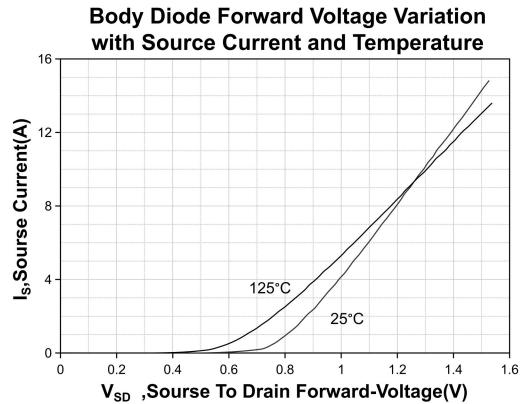
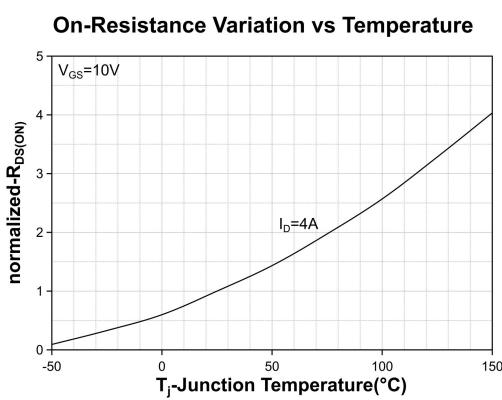
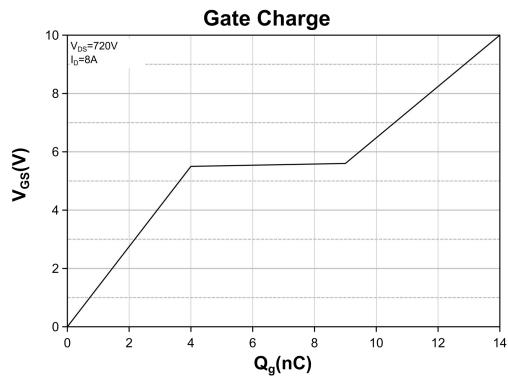
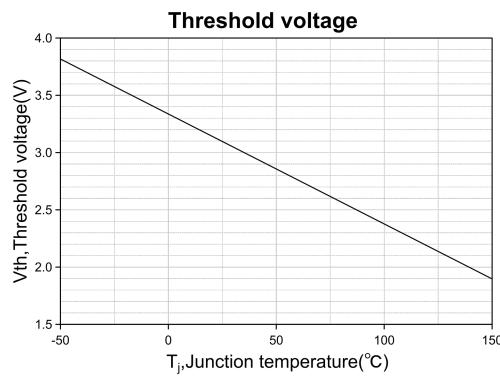
| Marking    | Package |
|------------|---------|
| MS8N90ICD0 | TO-252  |

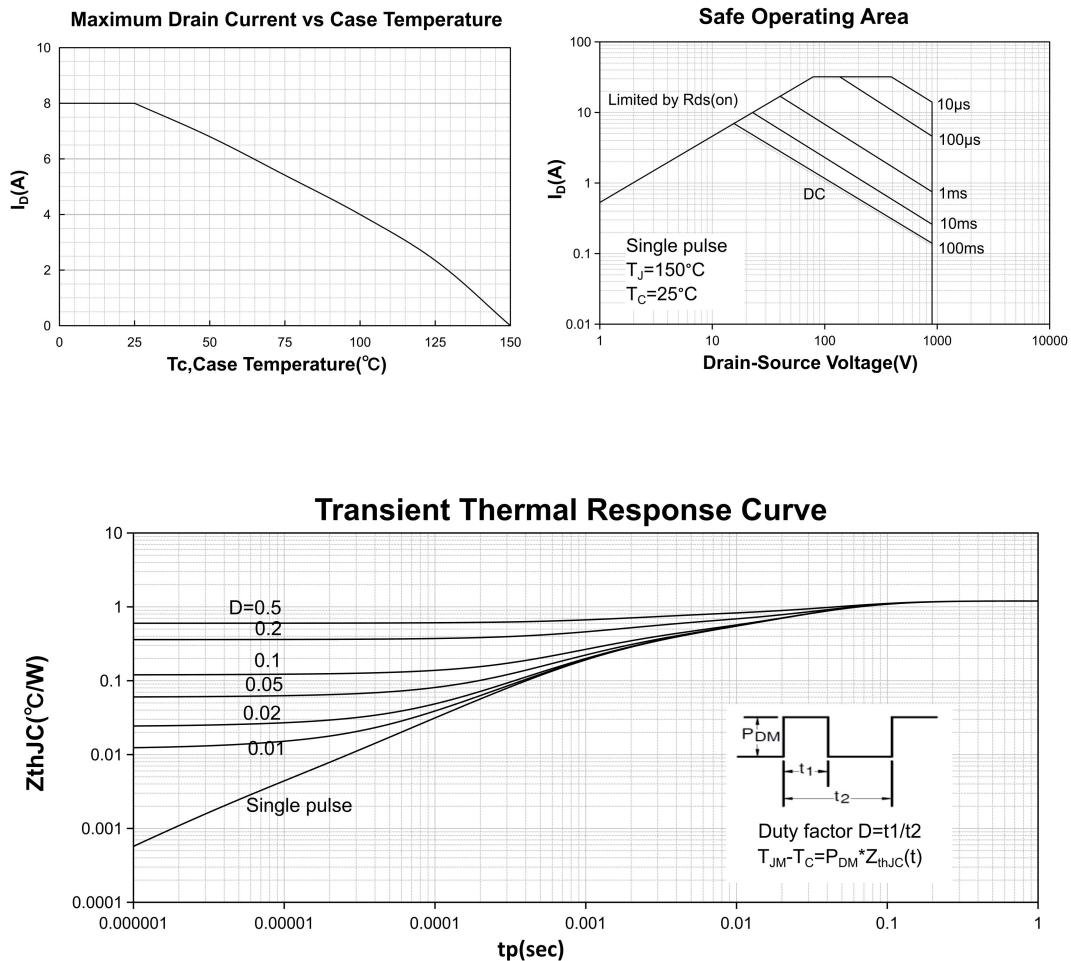
Notes:

1. Pulse width limited by maximum junction temperature
2.  $I_{AS}=I_{AR}$ ,  $V_{DD}=50V$ ,  $R_G=25 \Omega$ , Starting  $T_J=25^\circ C$
3.  $I_{SD} \leq 8A, di/dt \leq 200A/\mu s, V_{DD} \leq BV_{DSS}$ , Starting  $T_J=25^\circ C$
4.  $V_{DS} \leq 720V$
5. Pulse Test: Pulse Width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$
6. Essentially independent of operating temperature

## ELECTRICAL CHARACTERISTICS (curves)







## PACKAGE MECHANICAL DATA

